

**Notice of References Cited**

Application/Control No.

10/551,784

Applicant(s)/Patent Under  
Reexamination  
BAEK ET AL.

Examiner

ROBERT EOM

Art Unit

1797

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,076,420	02-1978	De Maeyer et al.	356/73
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

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